

Testing Summary Samsung Active II Tablet Full Docking Station

(7160-1005-00, 7160-1029-00)

Summary of Tests Performed at Gamber-Johnson

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Test Description	Test Parameters	
Vibration –	MIL-STD-810G, Method 514.6, Procedure 1, Category 4, per Figure	
Operational	514.6C-1. Test duration is one hour along three mutually orthogonal	
Test date: Dec., 2017	axes – not simultaneously (3 hours total).	
	Unit is unlocked	
Vibration –	MIL-STD-810G, Method 514.6, Category 24, per Figure 514.6E-1. Test	
Non-Operational	duration is one hour along three mutually orthogonal axes – not	
(Minimum Integrity)	simultaneously.	
Test date: Dec., 2017	Unit is unlocked	
Functional Shock -	MIL-STD-810G, Method 516.6, Procedure 1, 3 positive and 3 negative	
Non-Operational	pulses each axis (vertical, longitudinal and transverse), 18 pulses	
Test date: Dec., 2017	20G, 11ms half sine	
	Unit is unlocked	
Mechanical Shock	MIL-STD-810G, Method 516.6, Procedure 1, 3 positive and 3 negative	
Safety -	pulses each axis (vertical, longitudinal and transverse), 18 pulses	
Non-Operational	40G, 11ms half sine	
Test date: Dec., 2017	Unit is unlocked	
Cycle Testing –	30,000 cycles of the docking connector, latching and locking	
Non-Operational	mechanisms	
Test date: Dec., 2017		
Electrostatic	ISO 10605, Section 8, Table C.2, Category 2 – Direct Air Discharge	
Discharge –		
Operational		
Test date: Dec., 2017		

Summary of Tests Performed at Independent Facility

Test Description	Test Parameters
Humidity	MIL-STD 810G, Method 507.5, Procedure II, Aggravated, Table 507.5-
Test date: Dec., 2017	IX
	 Ten 24-hour cycles, temperature varied from 30°C to 60°C to
	30°C at constant 95% relative humidity.
Low Temperature:	MIL-STD 810G, Method 502.5, Procedure II
Operational	 -20°C Operating, 24-hour duration
Test date: Dec., 2017	

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Low Temperature:	MIL-STD 810G, Method 502.5, Procedure I		
Storage	 -40°C Non-Operating, 24-hour duration 		
Test date: Dec., 2017			
High Temperature:	MIL-STD 810G, Method 501.5, Procedure II, Table 501.5-II, Induced		
Operational	Conditions		
Test date: Dec., 2017	 Five 24-hour cycles, temperature varied from 30°C to 60°C to 		
	30°C		
High Temperature:	MIL-STD 810G, Method 501.5, Procedure I, Table 502.5-III, Induced		
Storage	Conditions		
Test date Dec., 2017	 Seven 24-hour cycles, temperature varied from 33°C to 71°C 		
	to 33°C		
Shock – Crash Hazard	SAE J1455, Section 4.11.3.5, per Figure 13		
Test date: 6/5/2018	Unit is unlocked		
EMC Testing	ECE R10: 2014 Addendum 9, Revision 5		
Test date: Dec., 2017			
EMC Testing	EN 55032:2015		
Test date: Dec., 2017	CISPR 32 – Class A		
	FCC Part 15, Subpart B – Class A		
Safety Testing	60950		
Test date: Jan., 2018	 IEC 60950-1(ed. 2);am1;am2 		
	• EN60950-1:2006/A2:2013		
	• CAN/CSA C22.2 No. 60950-1:2007/A2:2014-10		
	• UL 60950-1:2007/R:2014-10		

Other Certifications

Description	
EN 50581:2012 RoHS2 Directive 2011/65/EU	